

**Notice of References Cited**

Application/Control No.

10/509,175

Applicant(s)/Patent Under  
Reexamination  
ADRIAN ET AL.

Examiner

Tam M. Nguyen

Art Unit

1797

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2006/0241329	10-2006	Heida, Bernd	585/809
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**NON-PATENT DOCUMENTS**

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